## Application/Control No. Applicant(s)/Patent Under Reexamination 10/784,928 **OZAKI ET AL.** Notice of References Cited Examiner Art Unit Page 1 of 1 2858 Anjan K. Deb **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 340/514 US-6,525,657 B1 02-2003 Wojcik, Jacek J. US-6,587,677 B1 07-2003 Hombach et al. 455/226.2 В US-2007/0063905 A1 03-2007 Garreau et al. 343/703 С US-US-Ε US-F US-G USн US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY G01R 29/08 EP1281977A 02-2003 EΡ Chauvin et al. N ٥ Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.